

RoHS

COMPLIANT

HALOGEN

**FREE** 

Rectifier



Vishay Siliconix

# N-Channel 25-V (D-S) MOSFET

PRODUCT SUMMARY					
V <sub>DS</sub> (V)	$R_{DS(on)}\left(\Omega\right)$	I <sub>D</sub> (A) <sup>a, g</sup>	Q <sub>g</sub> (Typ.)		
25	0.0094 at V <sub>GS</sub> = 10 V	20	8 nC		
	$0.012 \text{ at V}_{GS} = 4.5 \text{ V}$	20	OTIC		

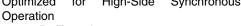
# PowerPAK SO-8

**Bottom View** 

Ordering Information: SiR874DP-T1-GE3 (Lead (Pb)-free and Halogen-free)

#### **FEATURES**

- Halogen-free According to IEC 61249-2-21 **Definition**
- TrenchFET® Gen III Power MOSFET
- Low Thermal Resistance PowerPAK® Package with Low 1.07 mm Profile
- Optimized for High-Side Synchronous





- 100 % UIS Tested
- Compliant to RoHS Directive 2002/96/EC

#### **APPLICATIONS**

- Notebook CPU Core
  - High-Side Switch
- Game Machine DC/DC High-Side
- Server DC/DC High-Side

N-Channel MOSFET

Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		$V_{DS}$	25	v	
Gate-Source Voltage		$V_{GS}$	± 20		
	T <sub>C</sub> = 25 °C		20 <sup>g</sup> 20 <sup>g</sup>		
Continuous Drain Current (T <sub>J</sub> = 150 °C)	$T_C = 70 ^{\circ}\text{C}$ $T_A = 25 ^{\circ}\text{C}$	I <sub>D</sub>	15 <sup>b, c</sup>		
	T <sub>A</sub> = 70 °C		12 <sup>b, c</sup>	A	
Pulsed Drain Current		I <sub>DM</sub>	50	^	
Continuous Source-Drain Diode Current	T <sub>C</sub> = 25 °C	1	20 <sup>g</sup>		
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	I <sub>S</sub>	3.2 <sup>b, c</sup>		
Single Pulse Avalanche Current	I = 0.1 mH	I <sub>AS</sub>	20		
Avalanche Energy L = 0.1 mH		E <sub>AS</sub>	20	mJ	
	T <sub>C</sub> = 25 °C		29.8		
Maximum Dawar Dissination	T <sub>C</sub> = 70 °C		19.0	w	
Maximum Power Dissipation	T <sub>A</sub> = 25 °C	P <sub>D</sub>	3.9 <sup>b, c</sup>	VV	
	T <sub>A</sub> = 70 °C		2.5 <sup>b, c</sup>	7	
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C	
Soldering Recommendations (Peak Temperature) <sup>d, e</sup>			260		

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient <sup>b, f</sup>	t ≤ 10 s	R <sub>thJA</sub>	27	32	°C/W	
Maximum Junction-to-Case (Drain)	Steady State	R <sub>thJC</sub>	3.5	4.2	- C/VV	

#### Notes:

- a. Base on T<sub>C</sub> = 25 °C.
- b. Surface Mounted on 1" x 1" FR4 board.
- c. t = 10 s.
- d. See Solder Profile (www.vishay.com/doc?73257). The PowerPAK SO-8 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework Conditions: manual soldering with a soldering iron is not recommended for leadless components.
- f. Maximum under Steady State conditions is 70 °C/W.
- g. Packaged Limited.

# SiR874DP

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Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static					l	
Drain-Source Breakdown Voltage	$V_{DS}$	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	25			V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	$V_{DS}/T_{J}$		34		
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I <sub>D</sub> = 250 μA		- 4.7		mV/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1.1		2.2	V
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 25 V, V <sub>GS</sub> = 0 V			1	μΑ
		V <sub>DS</sub> = 25 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55 °C			10	
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	V <sub>DS</sub> ≥ 5 V, V <sub>GS</sub> = 10 V	30			Α
Drain-Source On-State Resistance <sup>a</sup>		V <sub>GS</sub> = 10 V, I <sub>D</sub> = 10 A	0.0075		0.0094	
	R <sub>DS(on)</sub>	$V_{GS} = 4.5 \text{ V}, I_D = 7 \text{ A}$		0.010	0.012	Ω
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = 15 V, I <sub>D</sub> = 10 A		30		S
Dynamic <sup>b</sup>					l	
Input Capacitance	C <sub>iss</sub>			985		pF
Output Capacitance	C <sub>oss</sub>	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		205		
Reverse Transfer Capacitance	C <sub>rss</sub>			76		
Tatal Cata Charma	Qg	$V_{DS} = 15 \text{ V}, V_{GS} = 10 \text{ V}, I_{D} = 10 \text{ A}$		18	27	nC
Total Gate Charge				8	12	
Gate-Source Charge	$Q_{gs}$	$V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 10 \text{ A}$		2.4		
Gate-Drain Charge	$Q_{gd}$			2.3		
Gate Resistance	$R_{g}$	f = 1 MHz	0.3	1.3	2.6	Ω
Turn-On Delay Time	t <sub>d(on)</sub>			14	25	ns
Rise Time	t <sub>r</sub>	$V_{DD}$ = 15 V, $R_L$ = 1.5 $\Omega$		12	24	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 10 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$		19	35	
Fall Time	t <sub>f</sub>			9	18	
Turn-On Delay Time	t <sub>d(on)</sub>			8	16	
Rise Time	t <sub>r</sub>	$V_{DD}$ = 15 V, $R_L$ = 1.5 $\Omega$		10	20	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 10 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$		16	30	
Fall Time	t <sub>f</sub>			9	18	
Drain-Source Body Diode Characterist	ics			•	•	•
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C			20	А
Pulse Diode Forward Current <sup>a</sup>	I <sub>SM</sub>				50	
Body Diode Voltage	$V_{SD}$	I <sub>S</sub> = 3 A		0.76	1.1	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>			14	28	ns
Body Diode Reverse Recovery Charge	Diode Reverse Recovery Charge Q <sub>rr</sub>			5	10	nC
Reverse Recovery Fall Time	t <sub>a</sub>			8		
Reverse Recovery Rise Time	t <sub>b</sub>			6		ns

- a. Pulse test; pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2 %.
- b. Guaranteed by design, not subject to production testing.

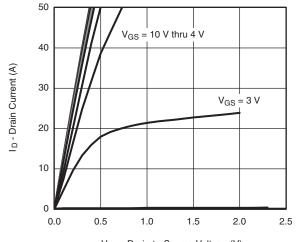
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.





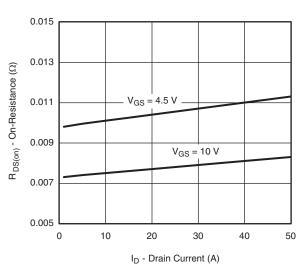
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# TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

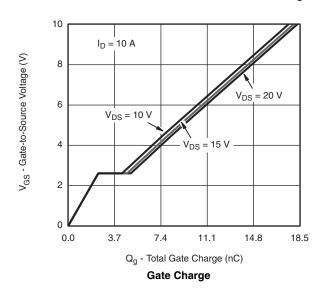


V<sub>DS</sub> - Drain-to-Source Voltage (V)

#### **Output Characteristics**



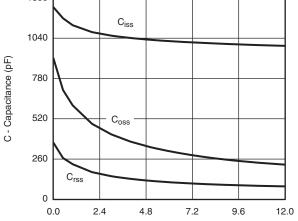
On-Resistance vs. Drain Current and Gate Voltage



8.0 6.4 I<sub>D</sub> - Drain Current (A) 4.8 3.2 T<sub>C</sub> = 25 °C T<sub>C</sub> = 125 °C 1.6 - 55 °C  $T_{C}$ 0.0 0

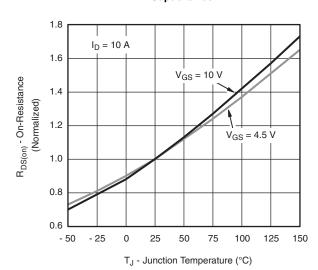
V<sub>GS</sub> - Gate-to-Source Voltage (V) **Transfer Characteristics** 





V<sub>DS</sub> - Drain-to-Source Voltage (V)

#### Capacitance



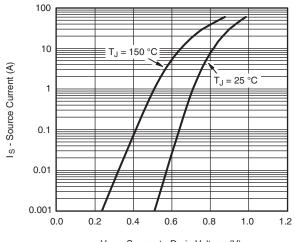
On-Resistance vs. Junction Temperature

# SiR874DP

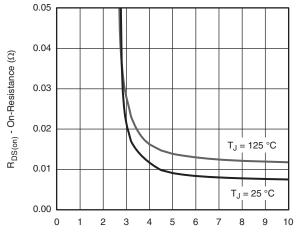
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# TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

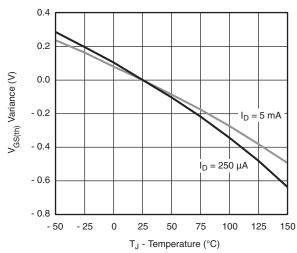


V<sub>SD</sub> - Source-to-Drain Voltage (V)

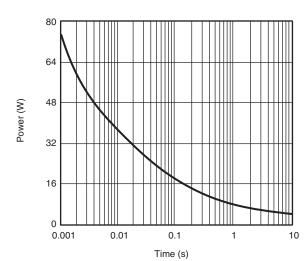


 $\label{eq:VGS} \mbox{V}_{GS} \mbox{ - Gate-to-Source Voltage (V)}$  On-Resistance vs. Gate-to-Source Voltage

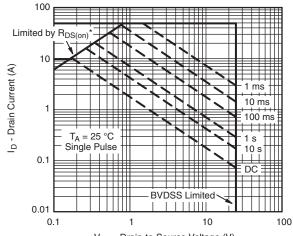
#### Source-Drain Diode Forward Voltage



Threshold Voltage



Single Pulse Power, Junction-to-Ambient



V<sub>DS</sub> - Drain-to-Source Voltage (V)

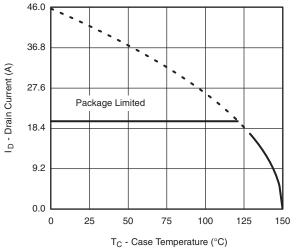
Safe Operating Area, Junction-to-Ambient

<sup>\*</sup>  $V_{GS}$  > minimum  $V_{GS}$  at which  $R_{DS(on)}$  is specified

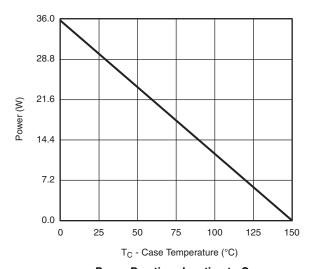


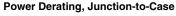
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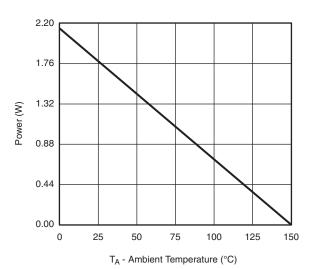
### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



#### **Current Derating\***







Power Derating, Junction-to-Ambient

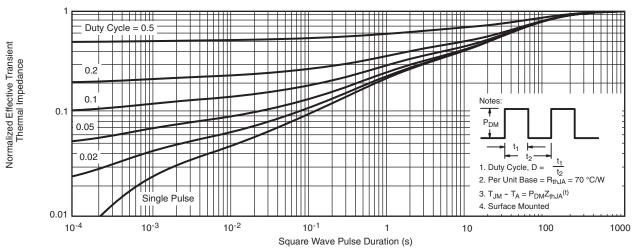
<sup>\*</sup> The power dissipation  $P_D$  is based on  $T_{J(max)} = 150$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

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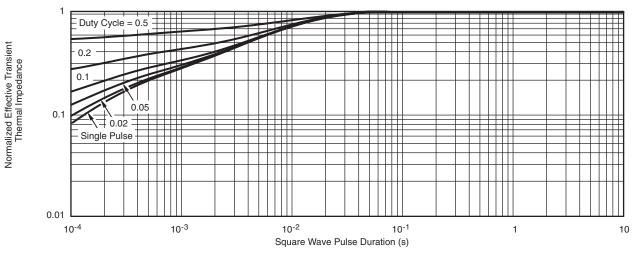
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### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



#### Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

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